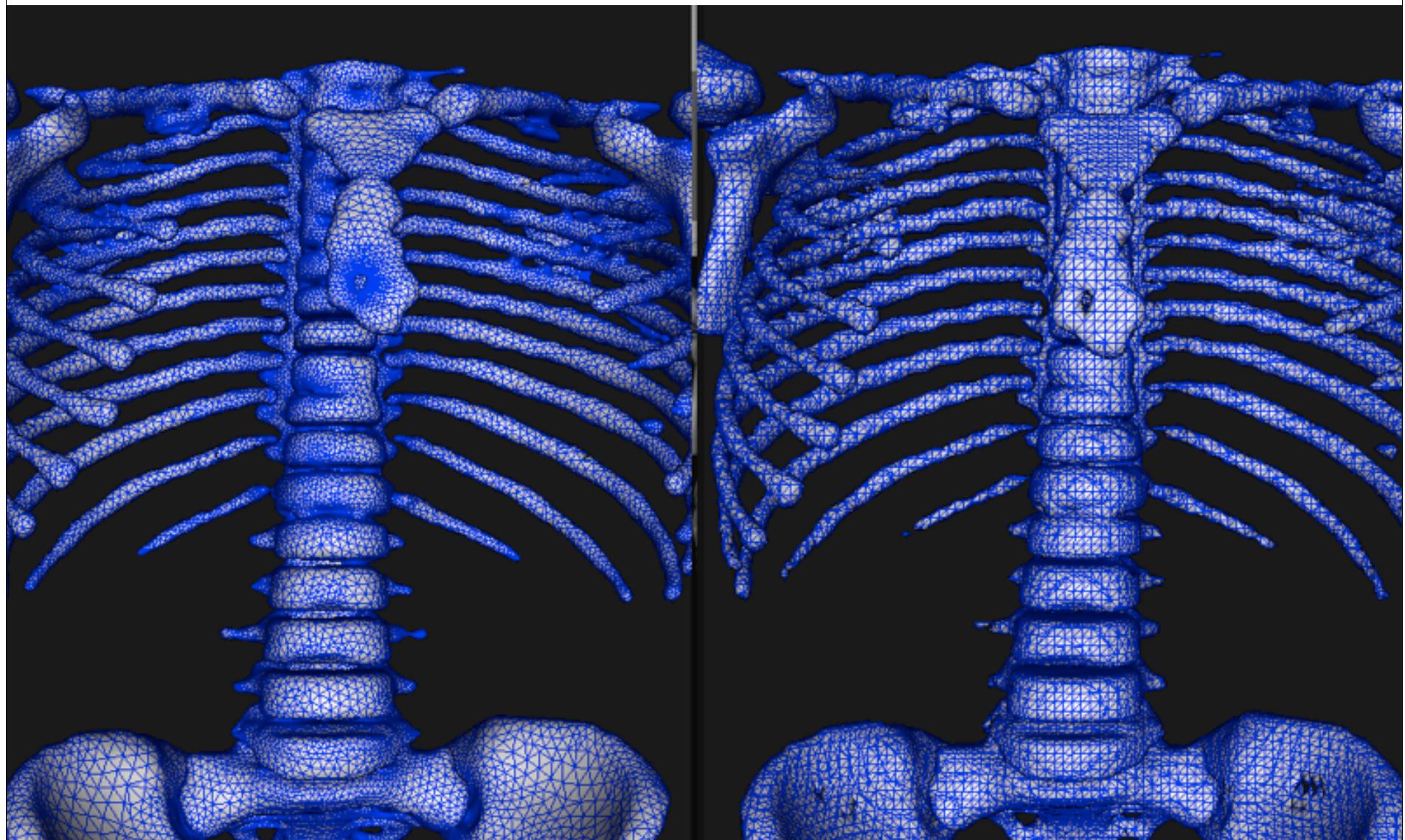
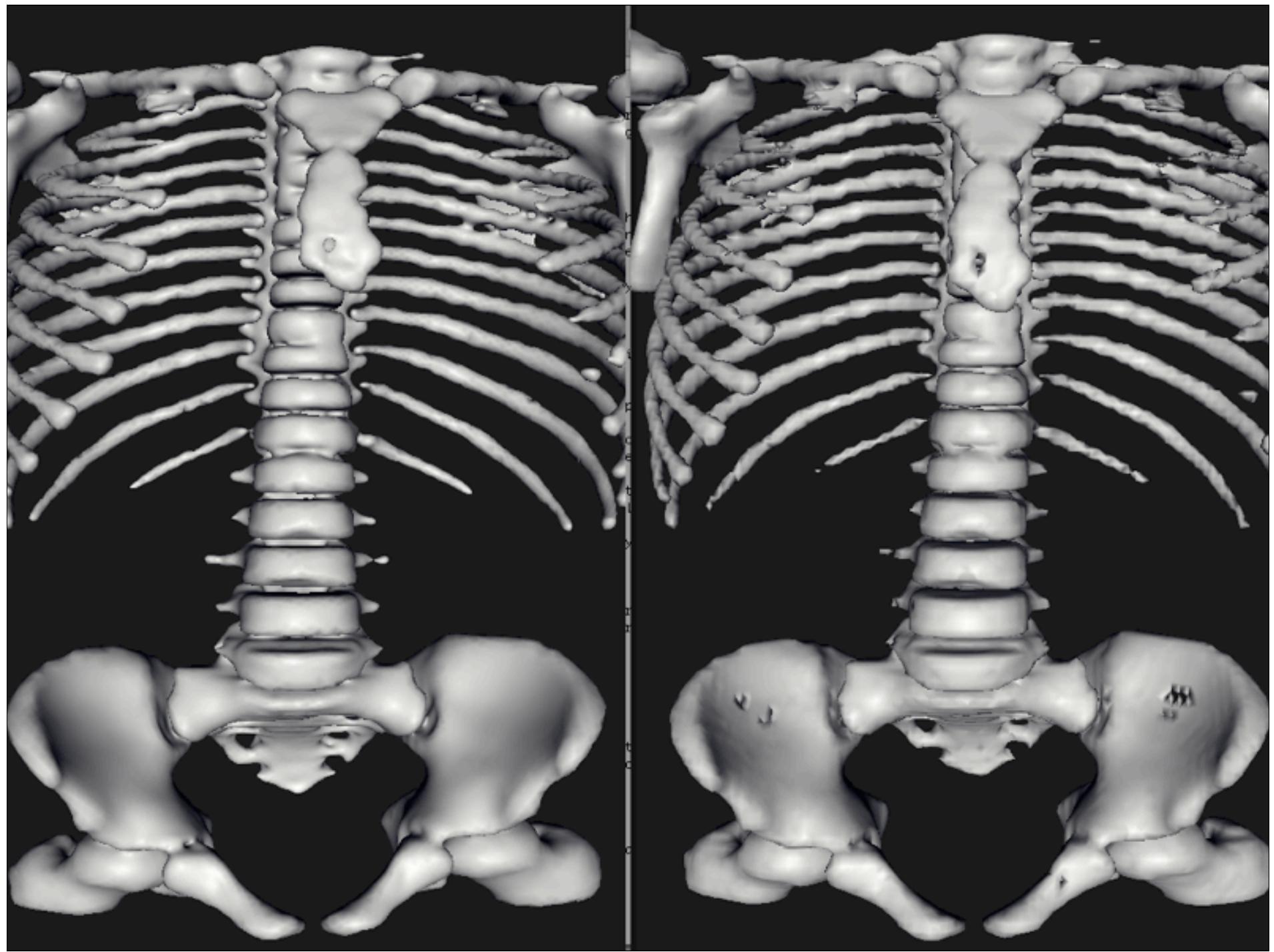
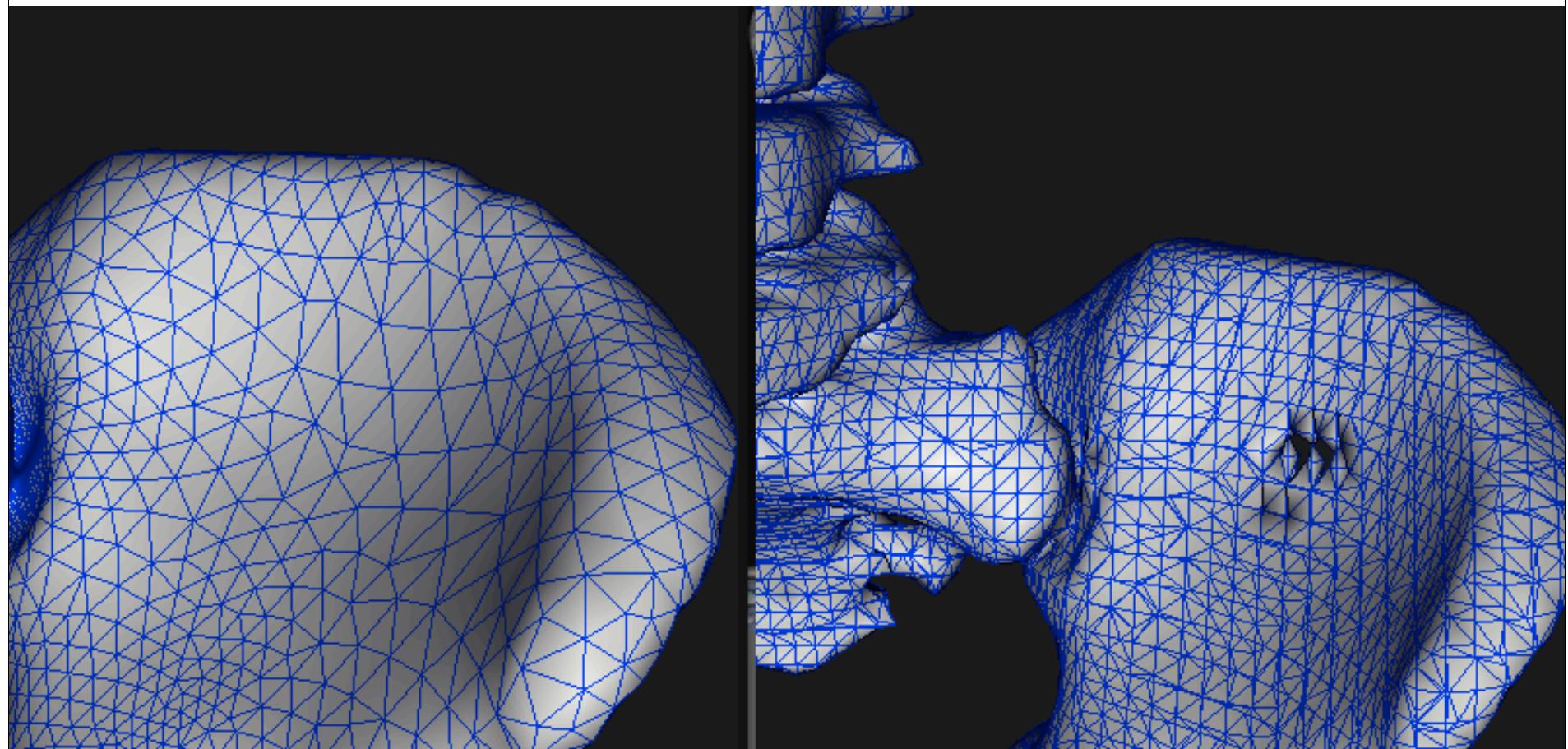


Computing High-Quality Isosurfaces

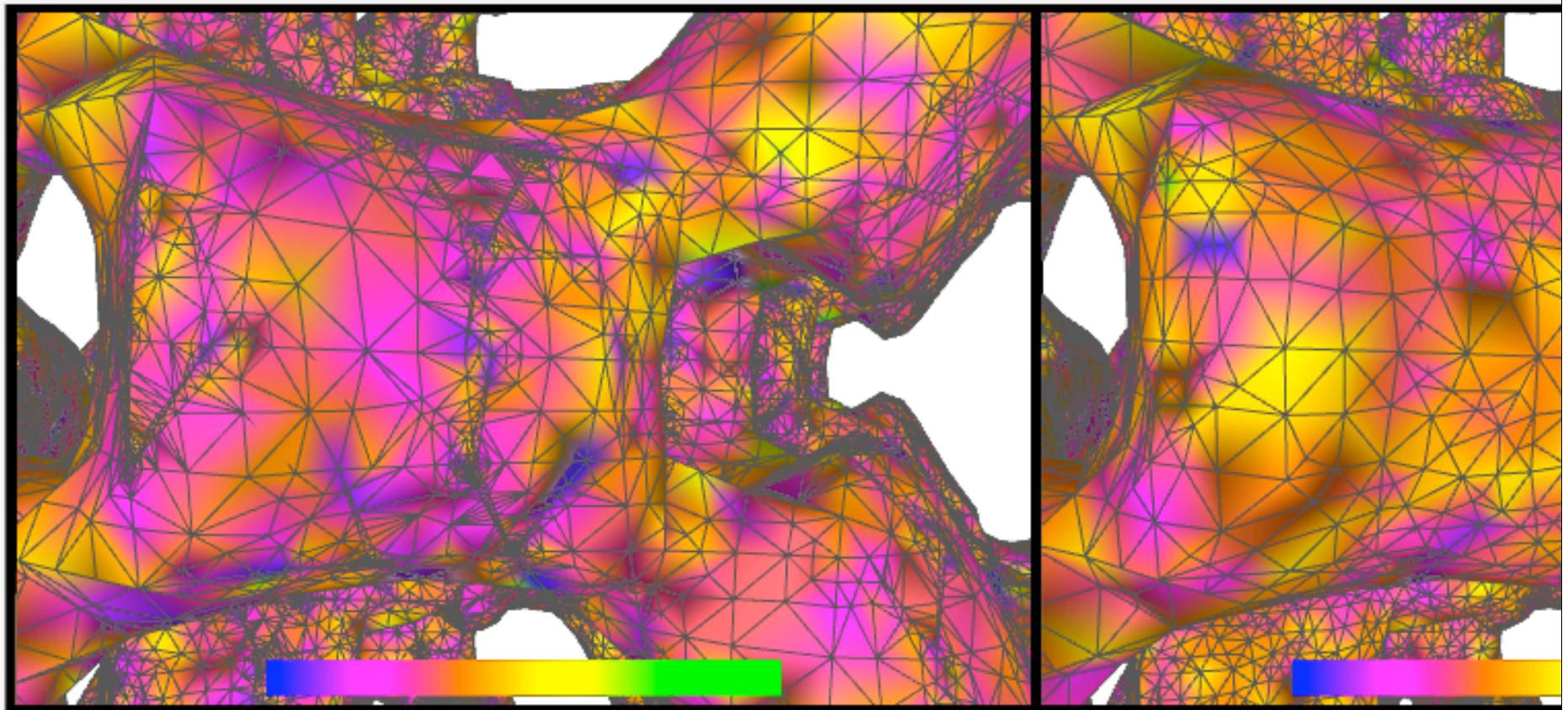
Visualization Algorithm Quality



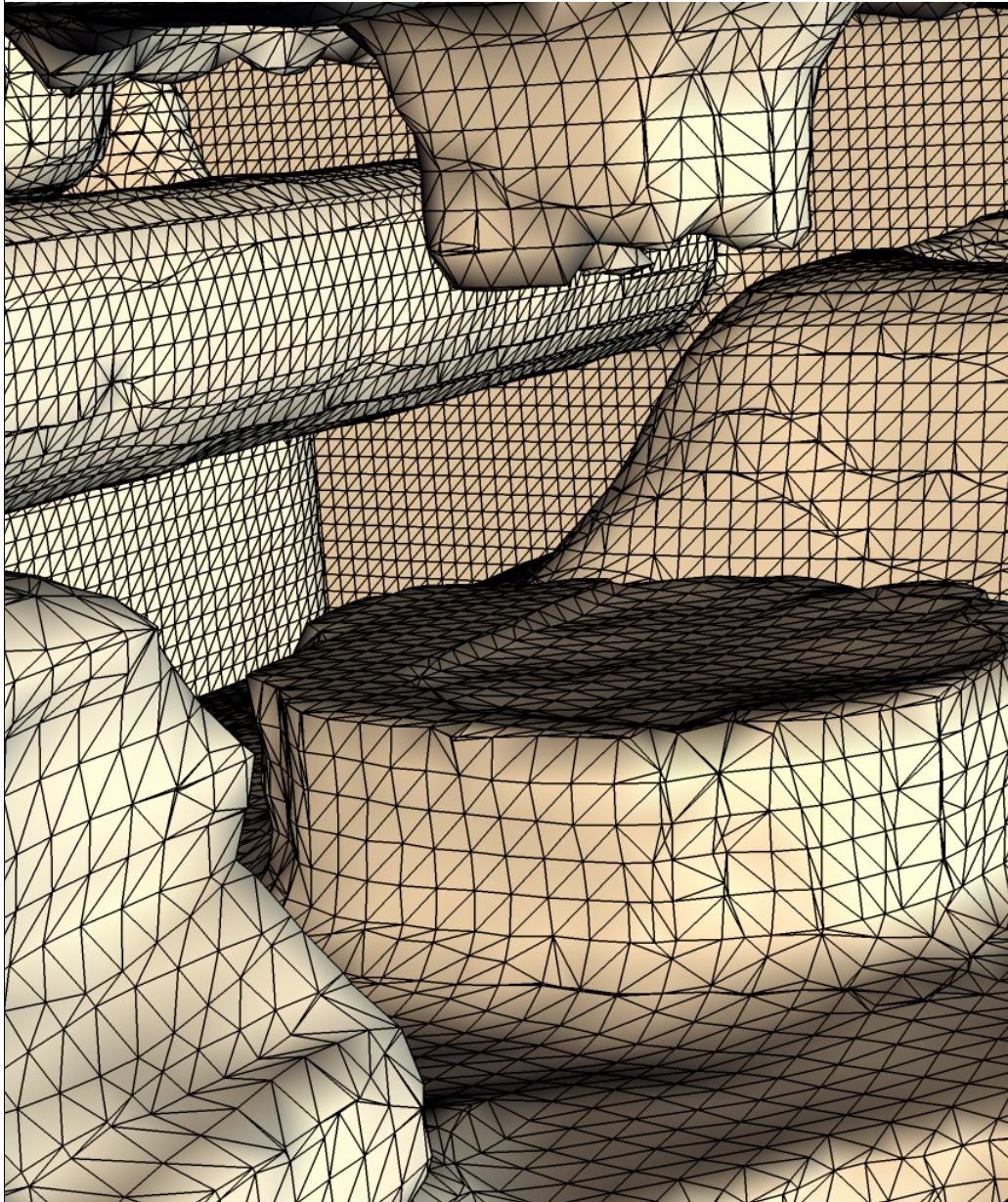




Implications: CDT quality



Isosurface
computed
by
Marching
Cubes



What Is a Good Linear Finite Element?
Interpolation, Conditioning, Anisotropy, and Quality Measures
(Preprint)

4

Jonathan Richard Shewchuk

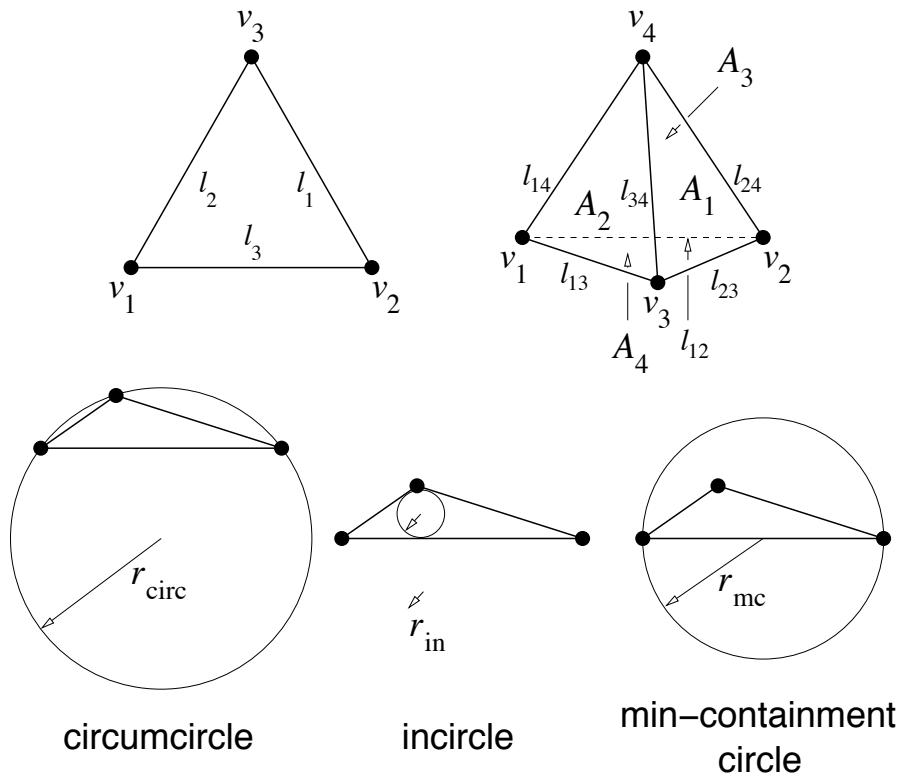
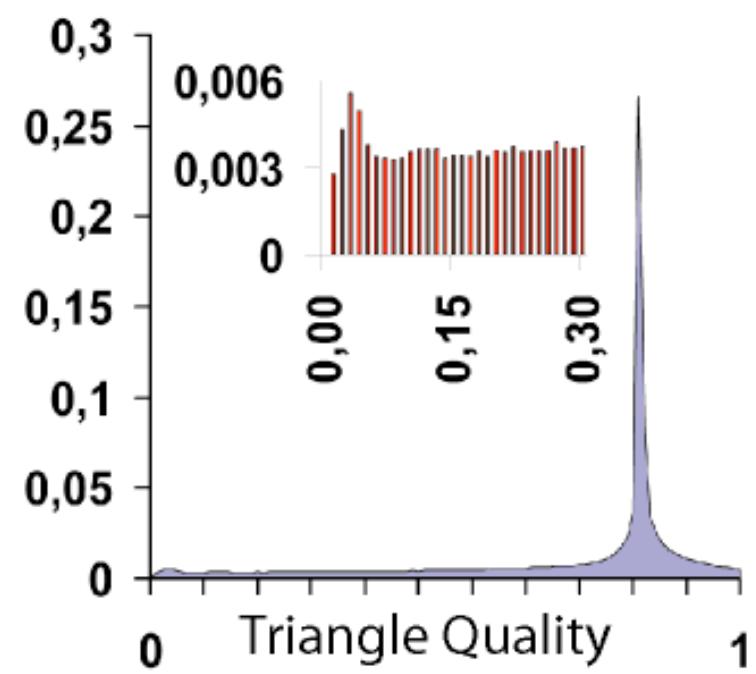
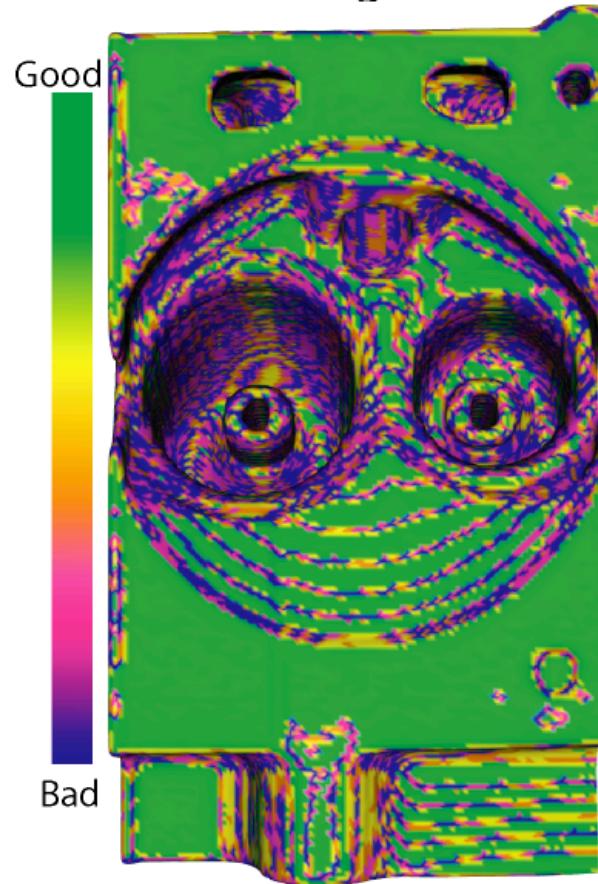
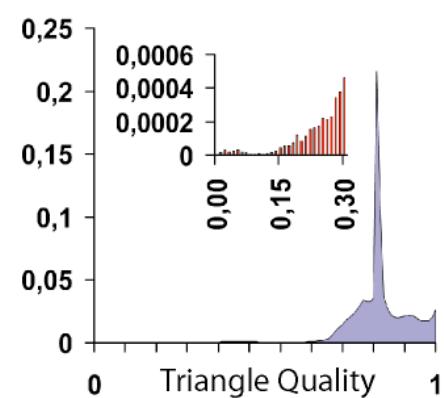
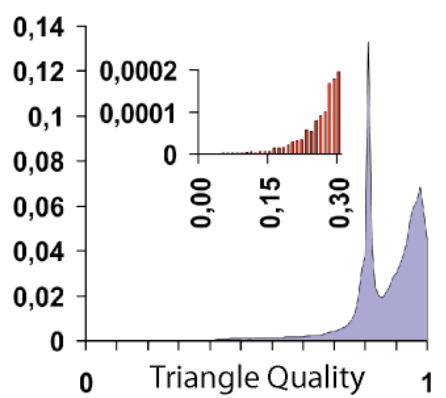
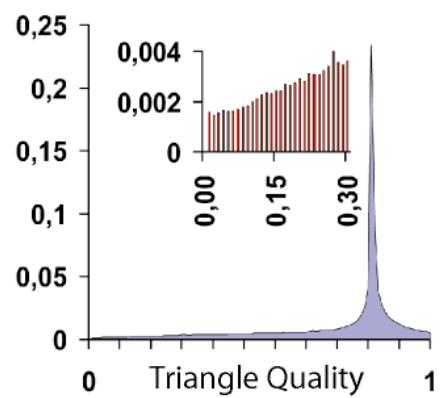
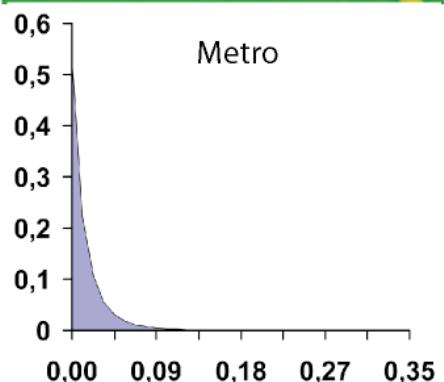
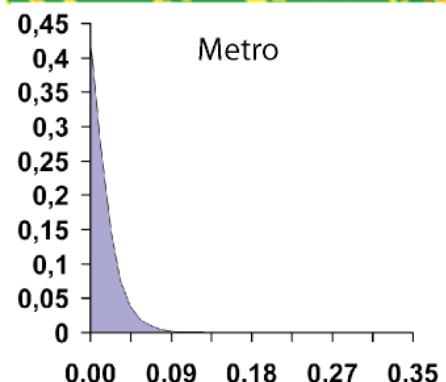
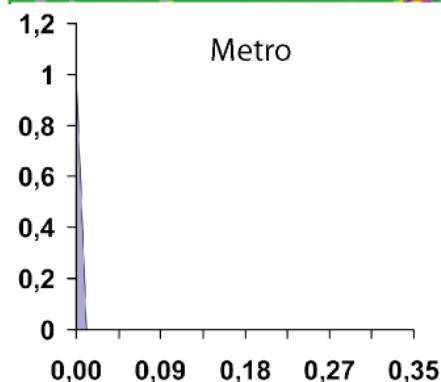
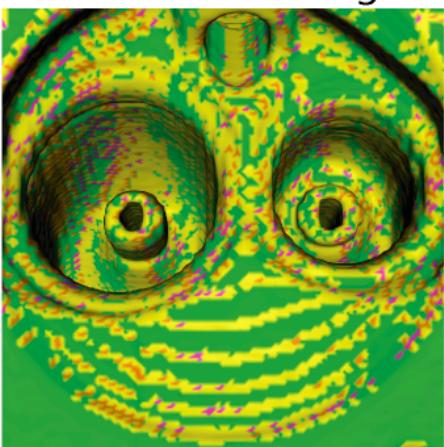
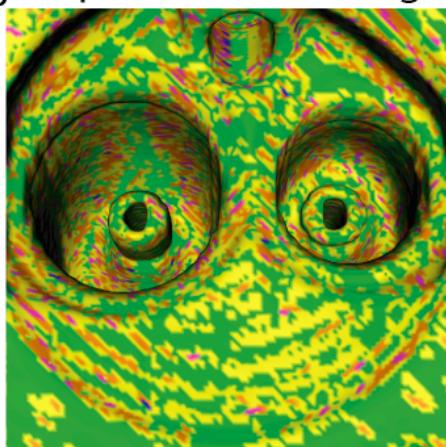
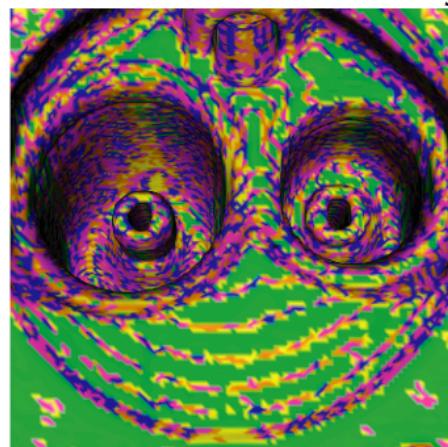


Figure 1: Quantities associated with triangles and tetrahedra.

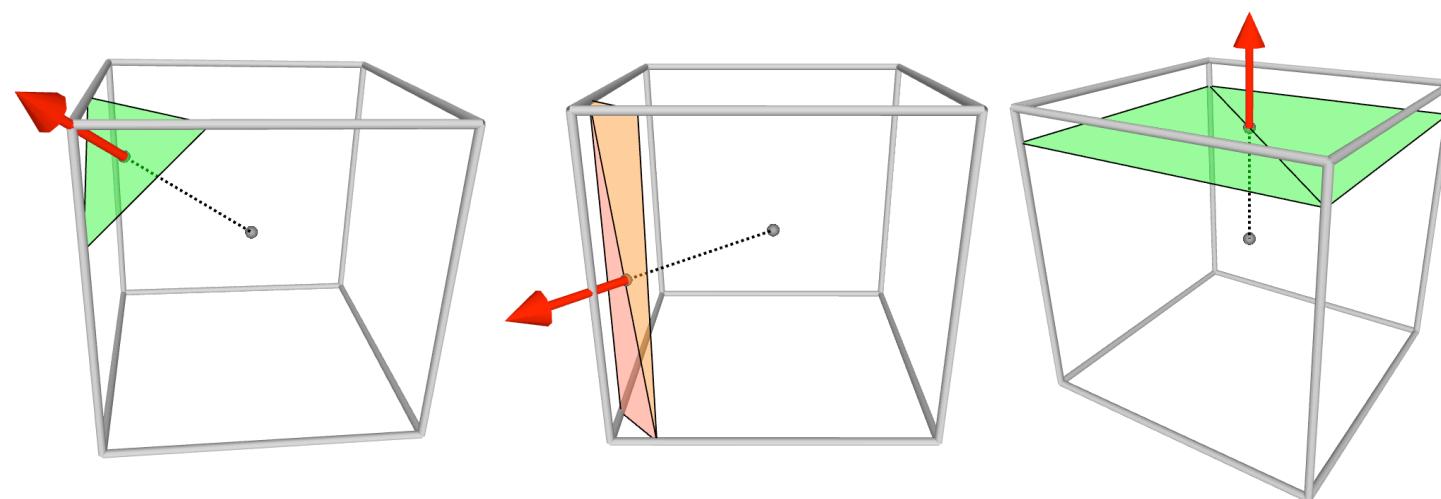
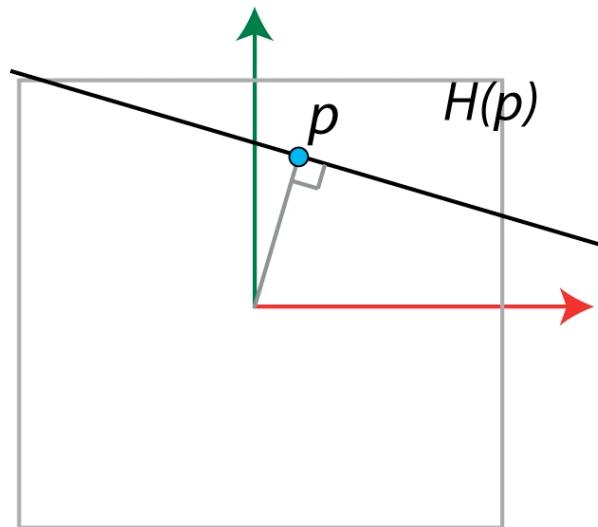
Marching Cubes



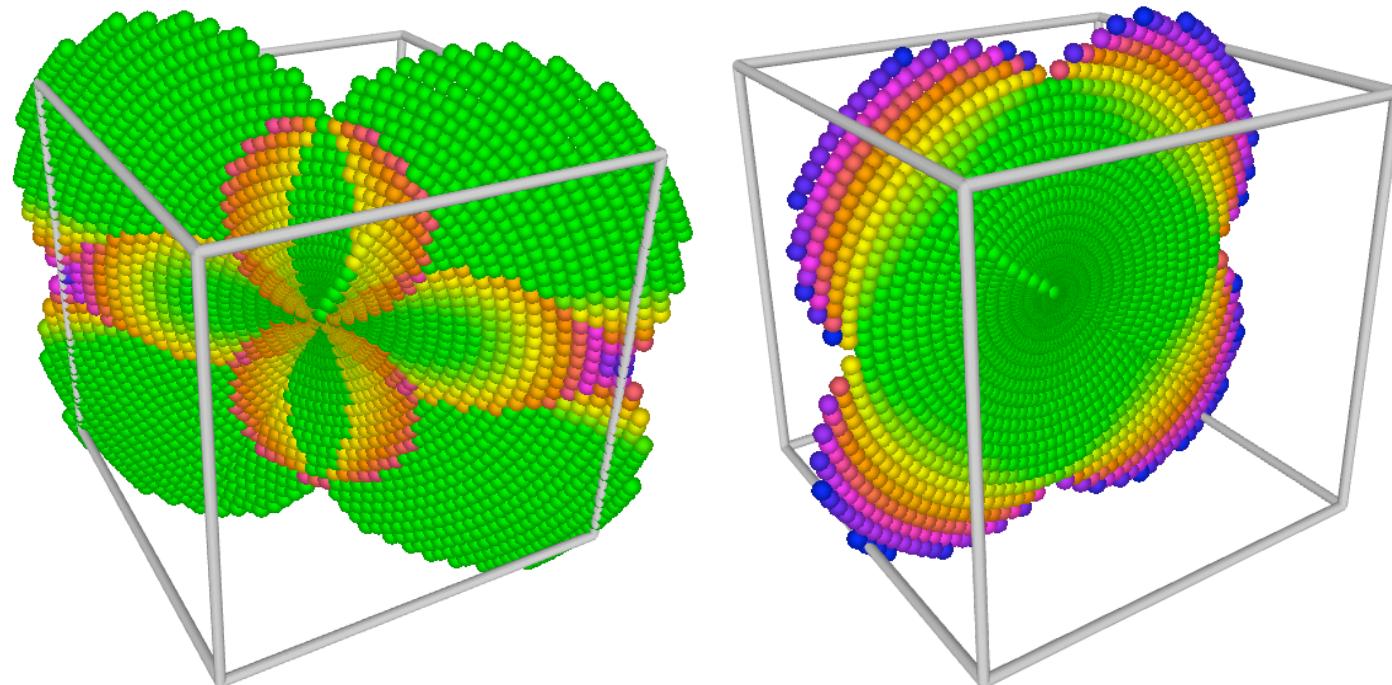
Decimation + Smoothing Laplacian Smoothing Dual Contouring



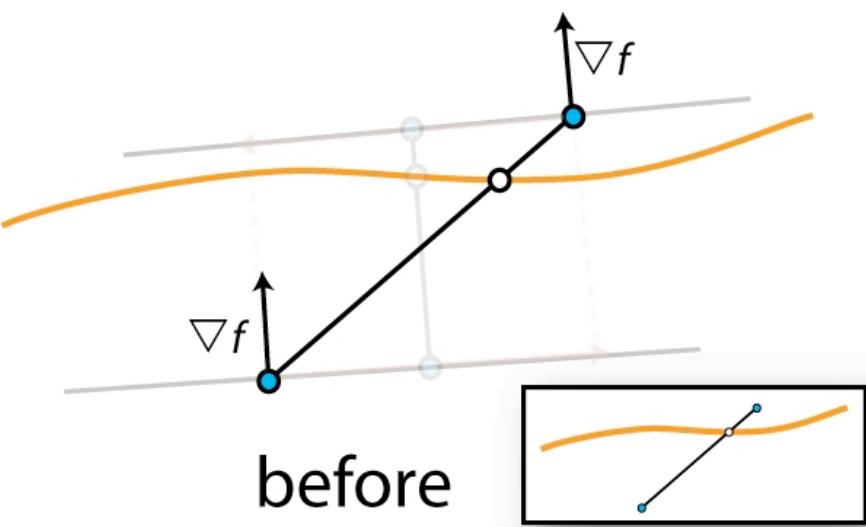
What is the source of bad triangles in MC?



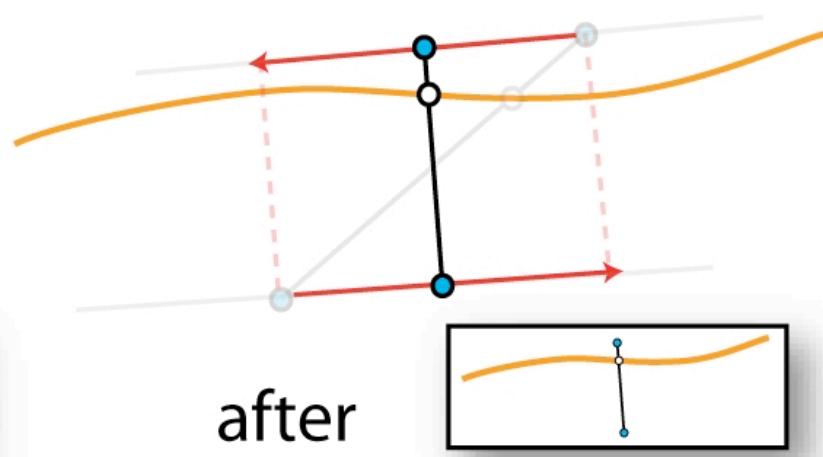
What is the source of bad triangles in MC?



Edge Transformations for Improving Mesh Quality of Marching Cubes

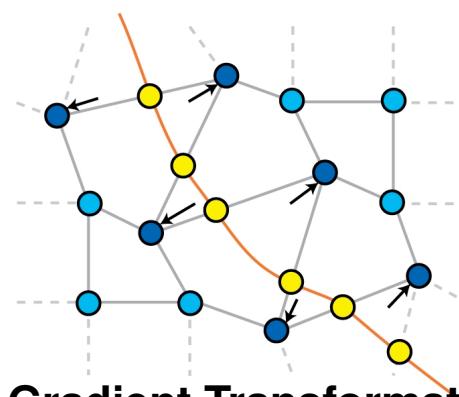
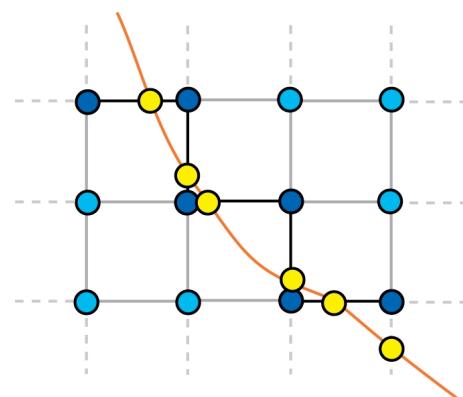


before

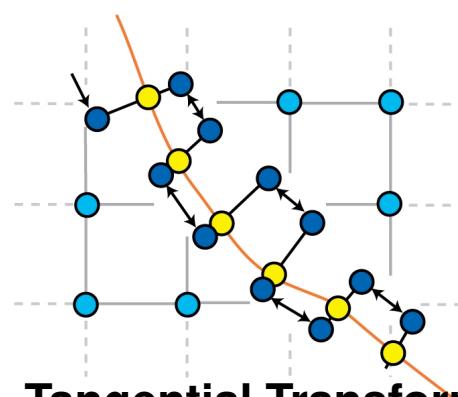


after

Fixing the problem: MACET

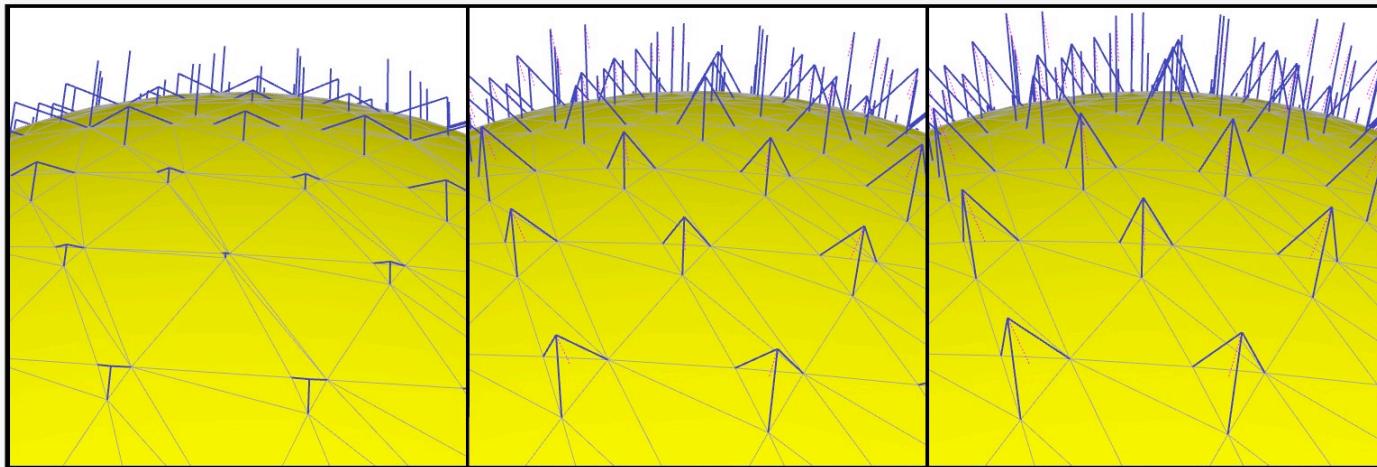


Gradient Transformation



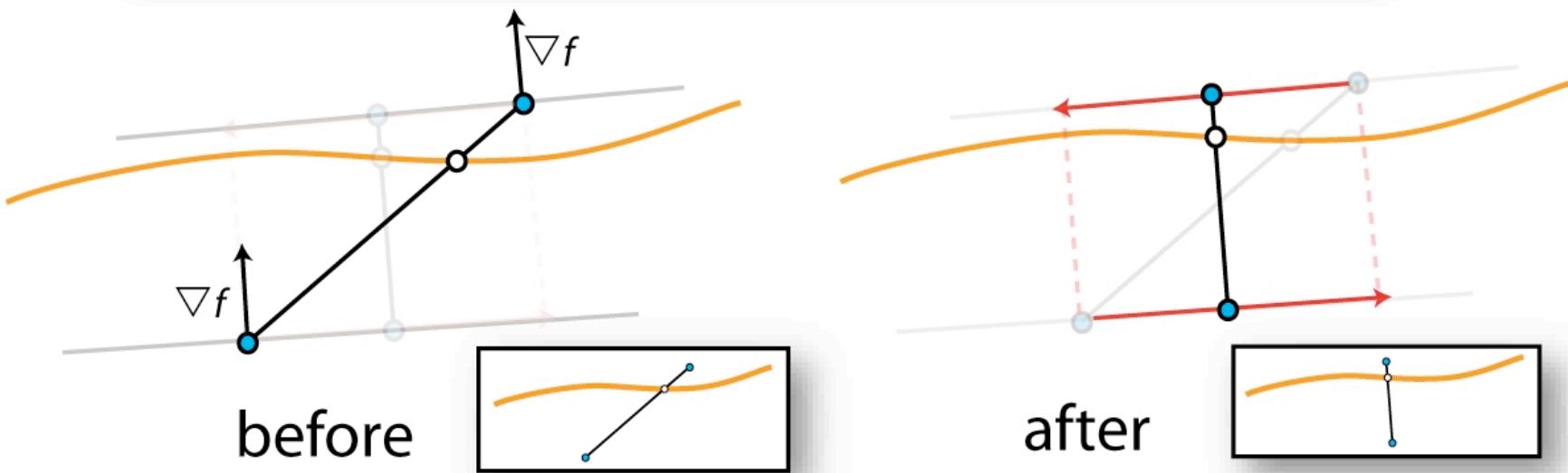
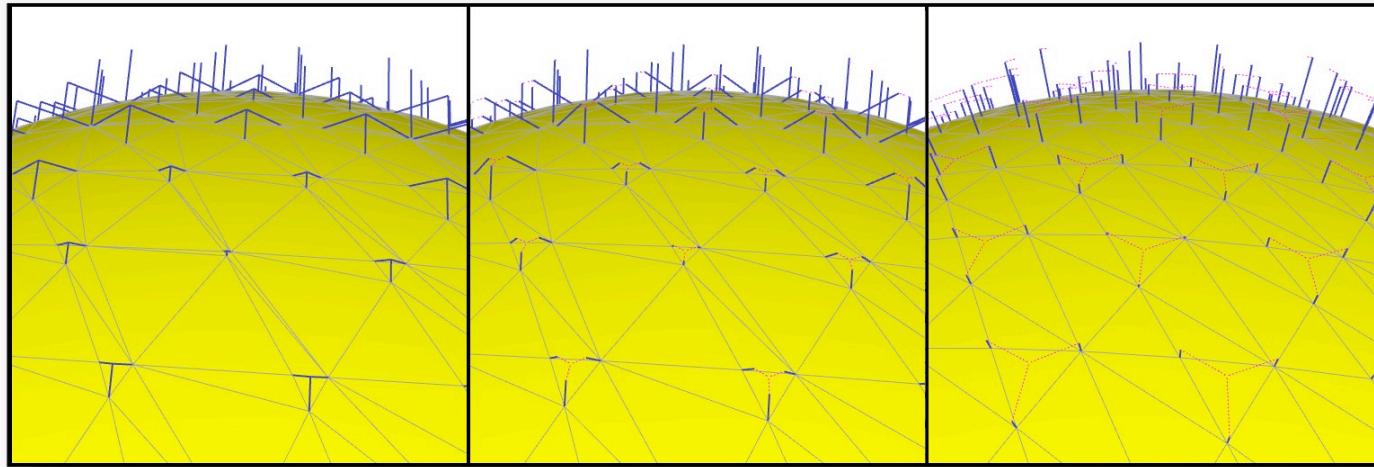
Tangential Transformation

Gradient Transformation

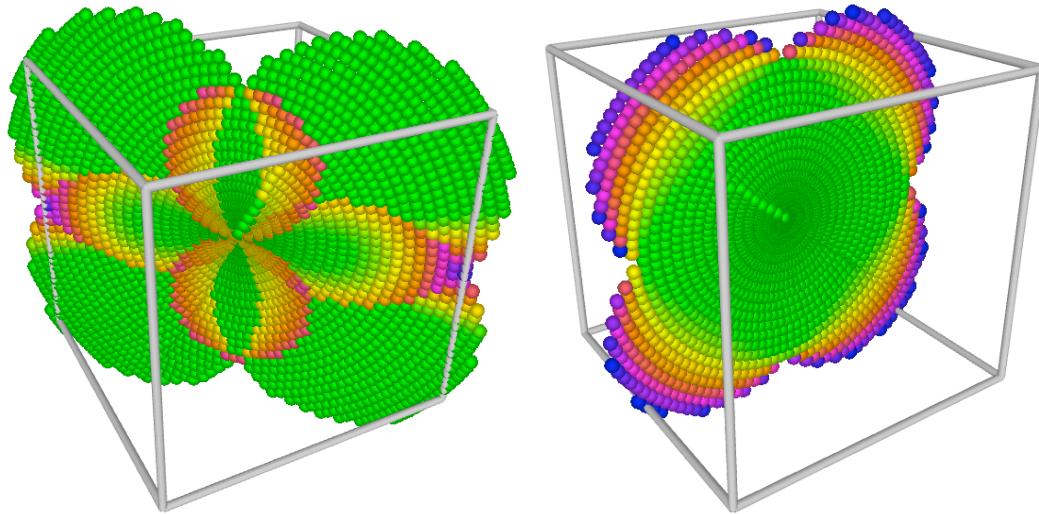


$$p' = p + \alpha \langle \nabla f(p'), \nabla f(p) \rangle \nabla f(p)$$

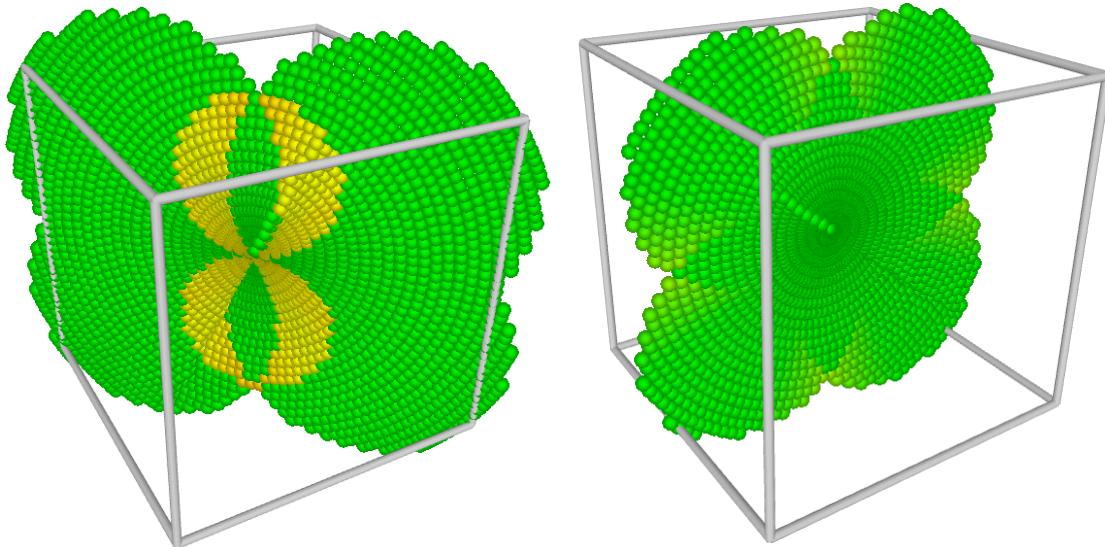
Tangential Transformation

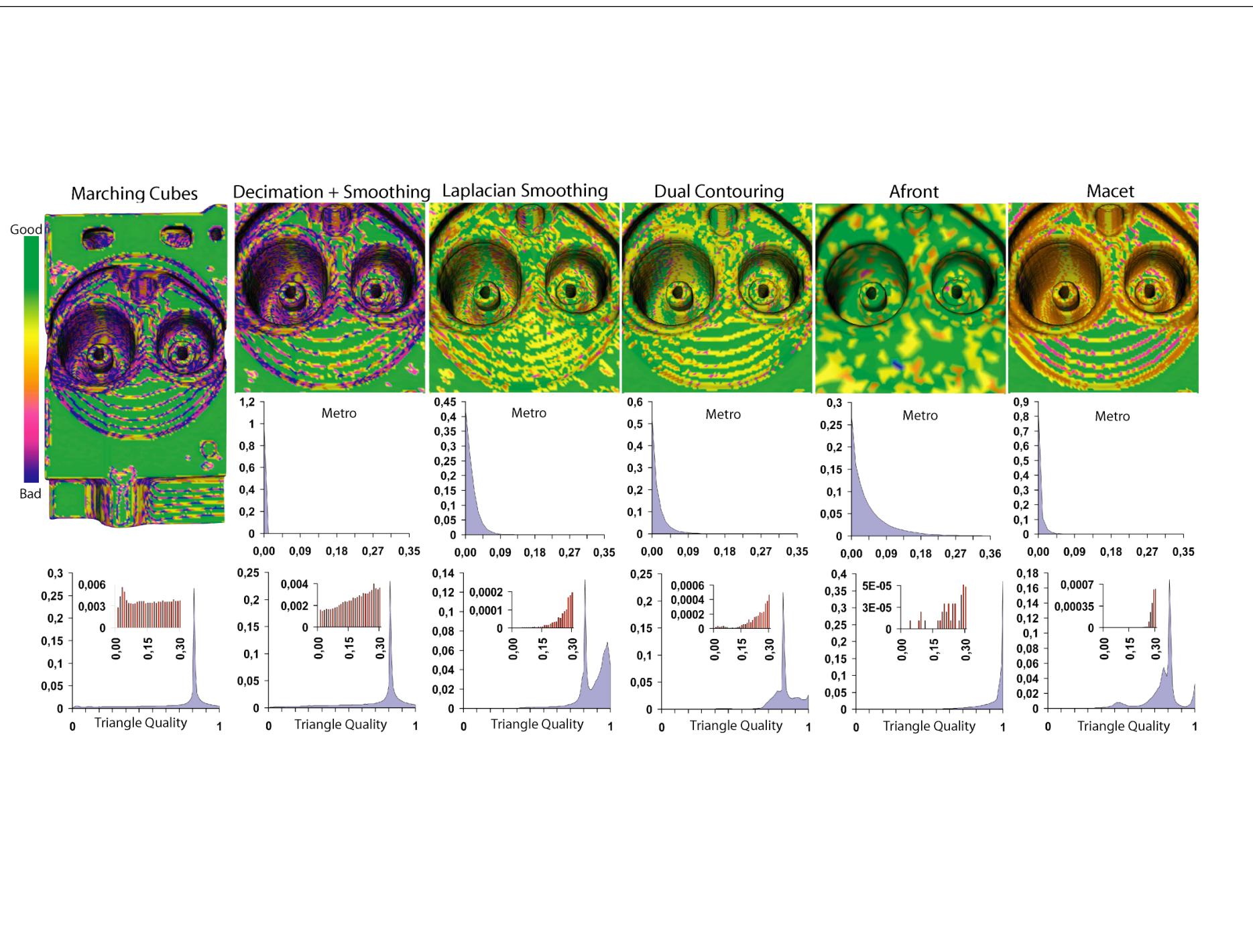


Marching Cubes:

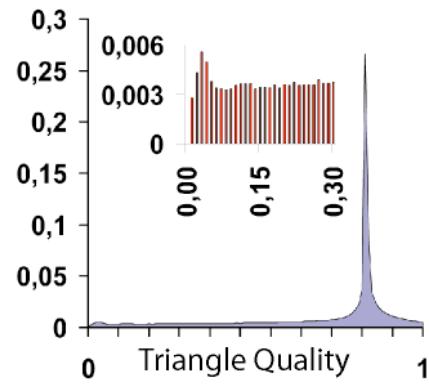
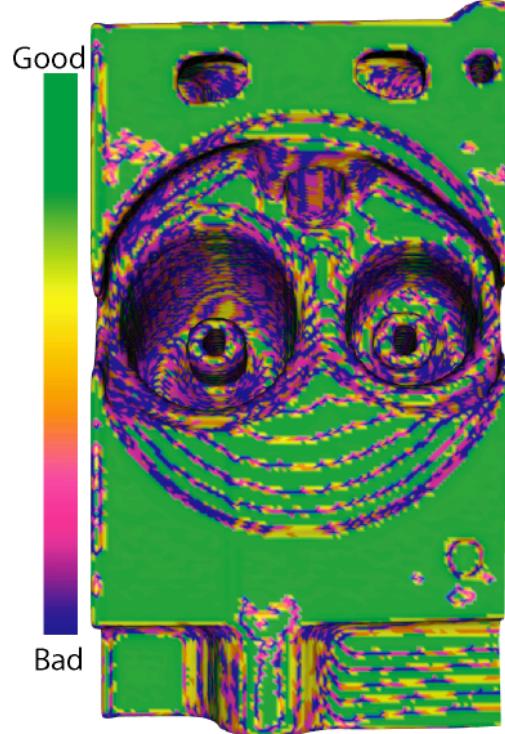


MACET:

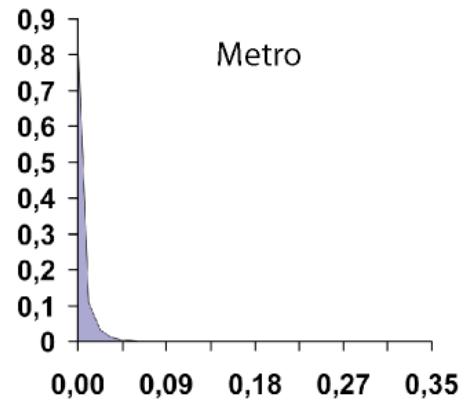
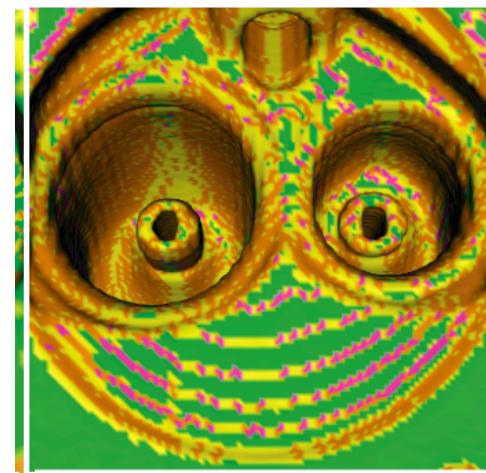




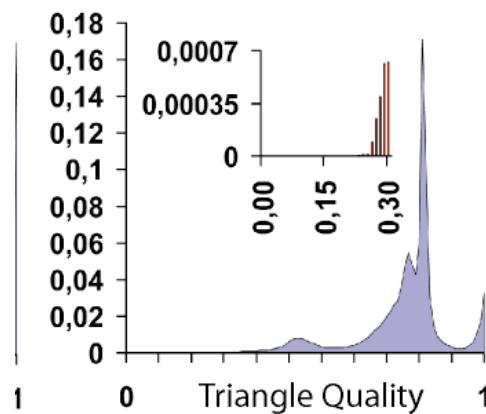
Marching Cubes



Macet



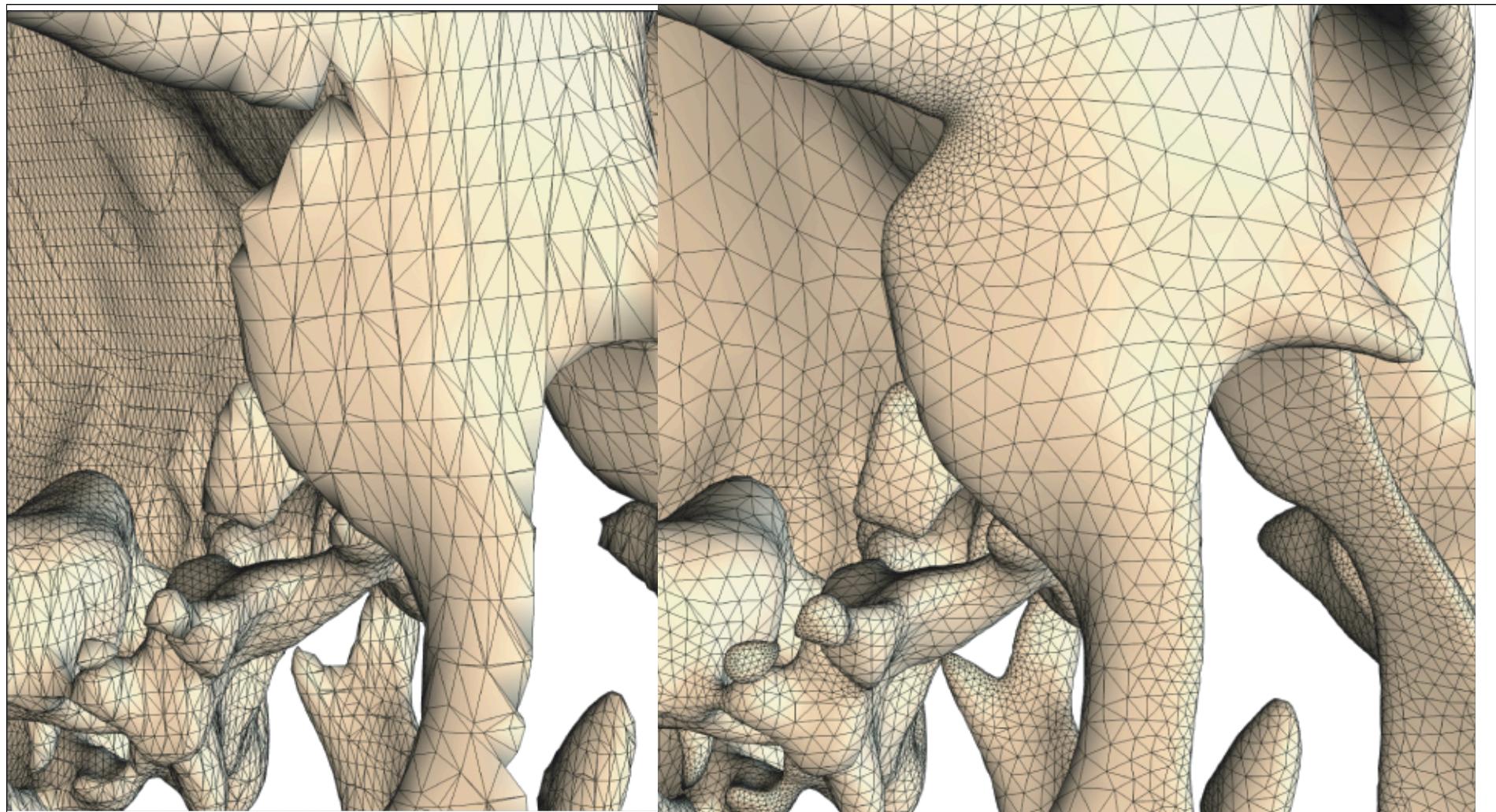
Metro



Edge Transformations for Improving Mesh Quality of Marching Cubes

Carlos Dietrich, Carlos Scheidegger, and John Schreiner, Joao Comba,,
Luciana Nedel, and C. Silva

Submitted for publication

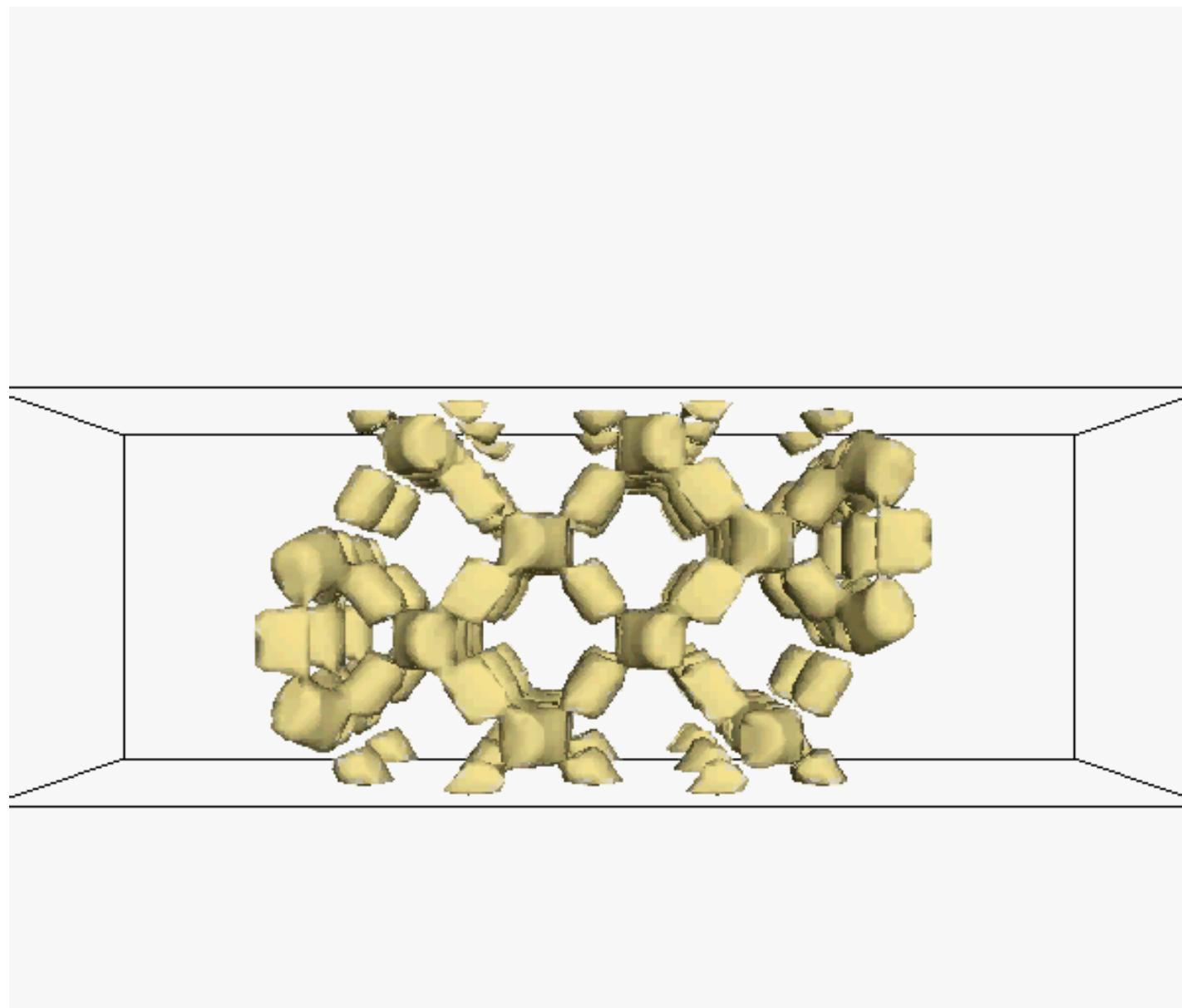


High-Quality Extraction of Isosurfaces from Regular and Irregular Grids

John Schreiner, Carlos Scheidegger, and Claudio T. Silva

IEEE Transactions on Computer Graphics (Visualization 2006)

Video



$\text{TRIANGULATE}(f, \nabla f, H(f), k, \rho, \eta)$

```
1 let  $\mathcal{S}$  be defined by all  $x$  such that  $f(x) = k$ 
2  $g \leftarrow \text{GENERATE-SAMPLES}(\mathcal{S}, \nabla f, H(f))$  (see Section 4.1)
3  $\text{CULL}(g, \rho, \eta)$  (see Section 4.2)
4  $Active \leftarrow \text{SEED-FRONTS}(\mathcal{S})$  (see Section 3.2)
5 while  $|Active| > 0$ 
6   do  $front \leftarrow \text{GET-ANY-FRONT}(Active)$ 
7     if  $\text{OK-TO-ADD-TRIANGLE}(front, \rho, \eta)$ 
8       then  $\text{ADD-TRIANGLE-TO-FRONT}(front, \rho, \eta)$ 
9       else  $other \leftarrow \text{GET-INTERFERING-FRONT}(front)$ 
10      if  $other = front$ 
11        then  $(f1, f2) \leftarrow \text{SPLIT}(front)$ 
12           $\text{REMOVE-FRONT}(Active, \{front\})$ 
13           $\text{ADD-FRONT}(Active, \{f1, f2\})$ 
14      else  $new-front \leftarrow \text{MERGE}(front, other)$ 
15           $\text{REMOVE-FRONT}(Active, \{front, other\})$ 
16           $\text{ADD-FRONT}(Active, \{new-front\})$ 
```

Triangulation Constraints - I

$$\iota_{\mathcal{S}} : \mathcal{S} \rightarrow \mathbb{R}^+ \quad (\text{ideal edge size length})$$

$$\iota_{\mathcal{S}}(x) = \frac{2 \sin(\rho/2)}{\kappa_{\max}}$$

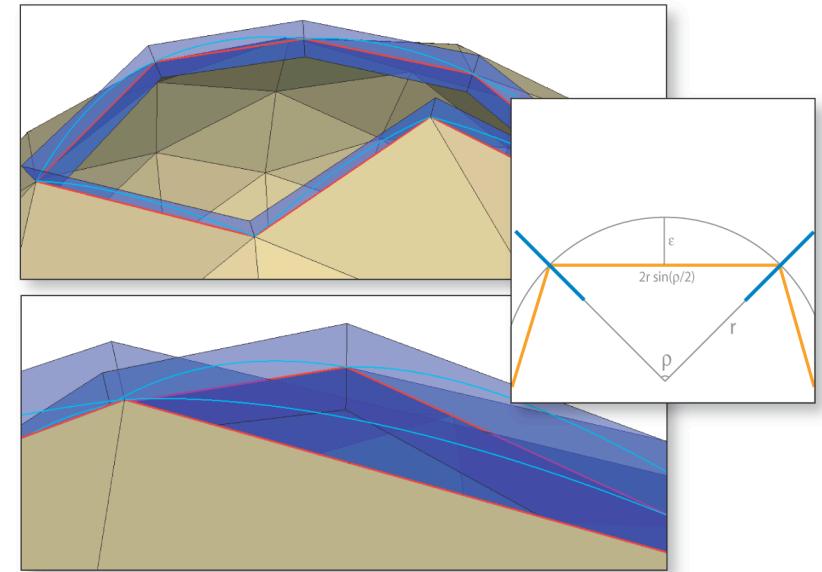
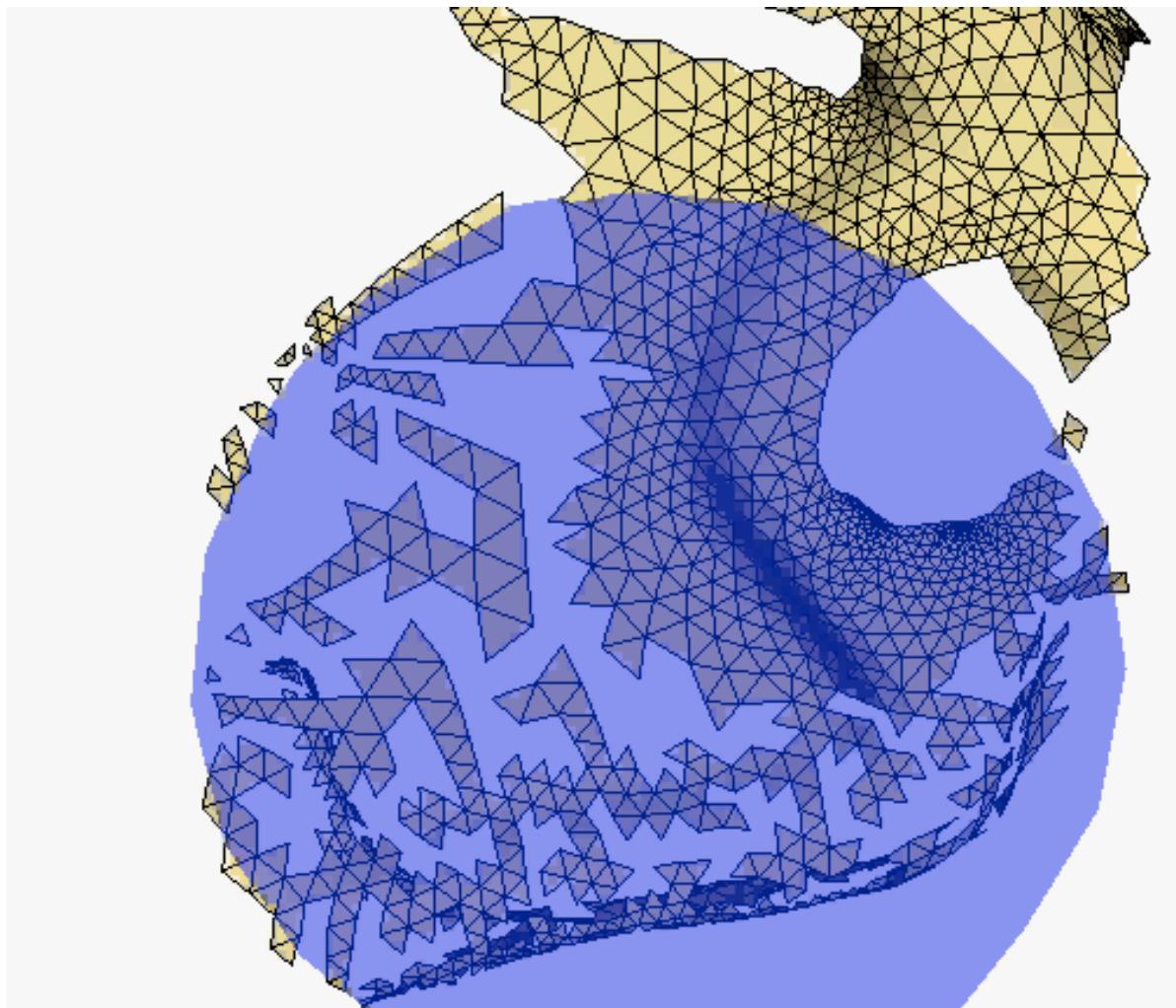


Figure 4: To robustly detect front interference, we use a set of fences: extensions of the front curve in the normal direction of the surface. We exploit the bound on the Hausdorff error to determine the correct fence height – the inset on the right shows the argument in two dimensions. $r = \kappa_{\max}^{-1}$.

The need for the guidance field



Triangulation Constraints - II

1. The triangles placed over a patch of surface must be a good approximation for the surface. In other words, the triangle edge size at s_i should be at most ι_i .
2. Triangle quality throughout the triangulation must be adequate. Specifically, we require that any two edges e_i and e_j incident to a common vertex have a ratio bounded by a user-defined parameter η :

$$\eta^{-1} \leq |e_i|/|e_j| \leq \eta \quad (1)$$

We have two user-defined parameters

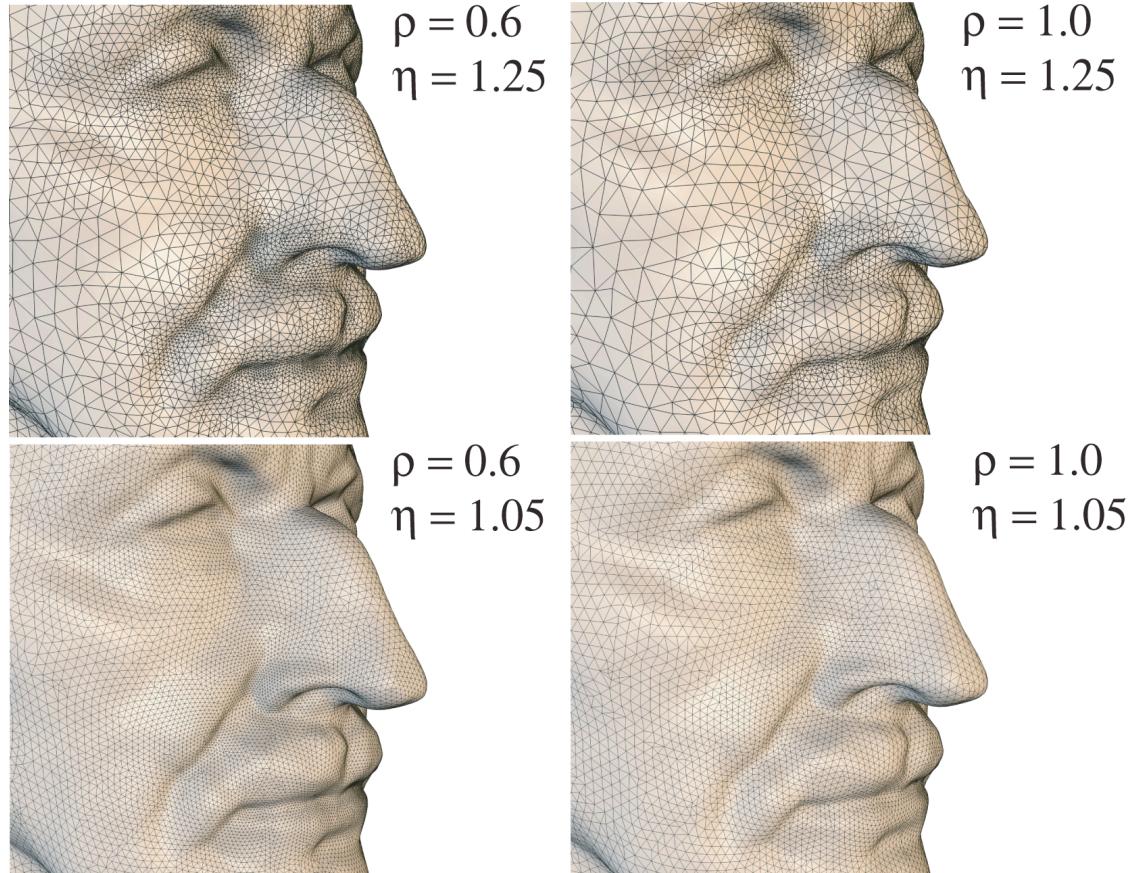


Figure 8: The effects of ρ and η on the resulting mesh. ρ controls the approximation accuracy: a bigger ρ will result in a coarser triangulation. η controls triangle grading: a larger η will result in more adaptive triangulations.

Defining the Guidance Field

$$g_S(x) : \mathbb{R}^3 \rightarrow \mathbb{R}^+ \quad (\text{guidance field})$$

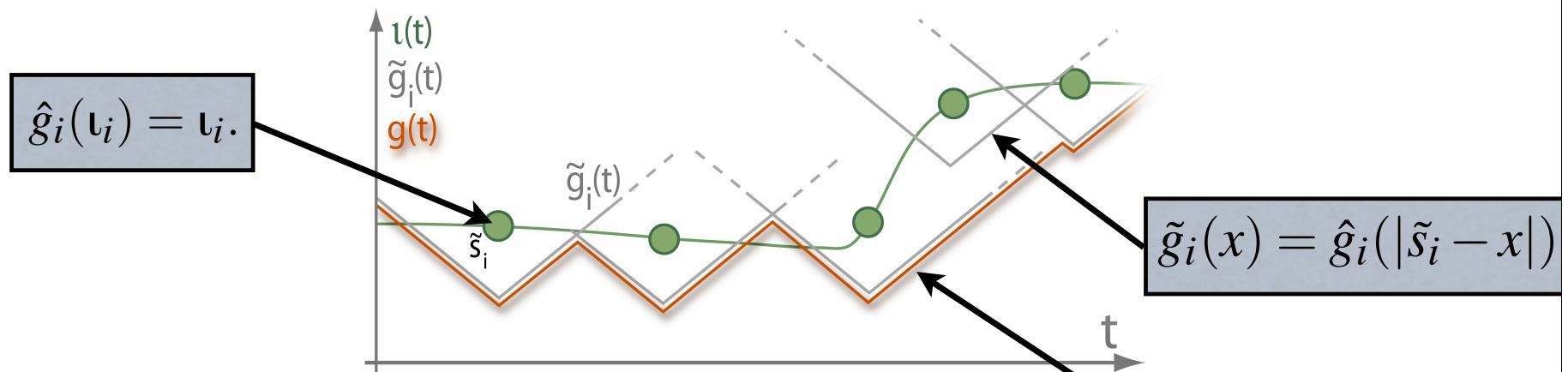


Figure 3: The guidance field $g(t)$ on a curve $t : \mathbb{R} \rightarrow S$. $g(t)$ is the minimum over all \tilde{g} . At the sample points \tilde{s}_i , \tilde{g}_i is minimum, and it grows linearly as the distance from \tilde{s}_i increases. Note that if the sampling is too coarse, $g(t)$ might not bound $\mathbf{l}(t)$, and that some of the samples might be unnecessary. Since each \tilde{g}_i is Lipschitz, so is $g(t)$.

$$\hat{g}_i(x) = (1 - \eta^{-1})x + \eta^{-1}\mathbf{l}_i$$

(see paper for complete details)

Results

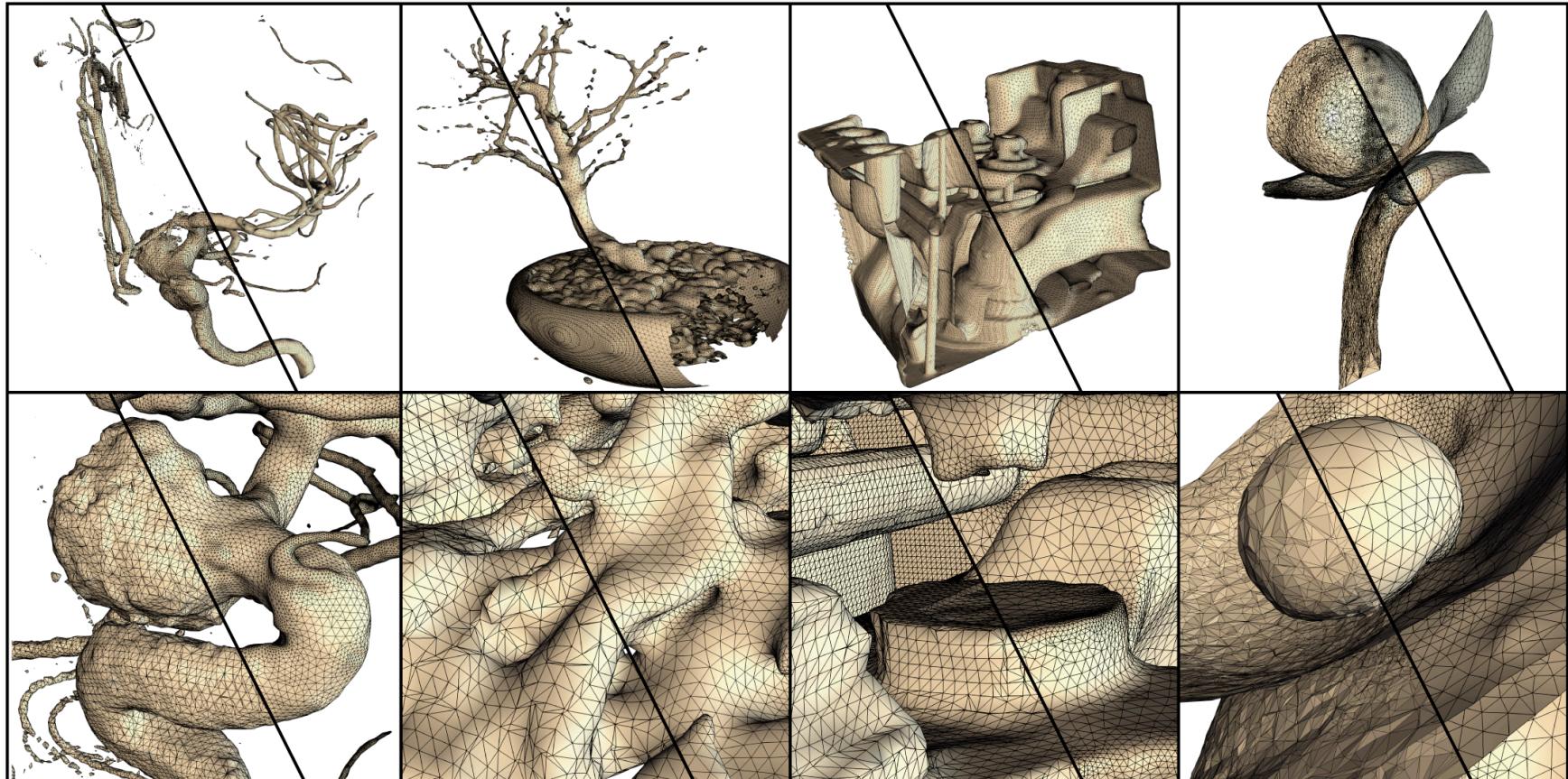


Figure 6: Some results of our algorithm, compared to MC and MT. From left to right: CT scans of an aneurism, a bonsai and an engine block, and isopotential surfaces of a human torso simulation. The first three datasets are regular grids, while the last one is a tetrahedral mesh.

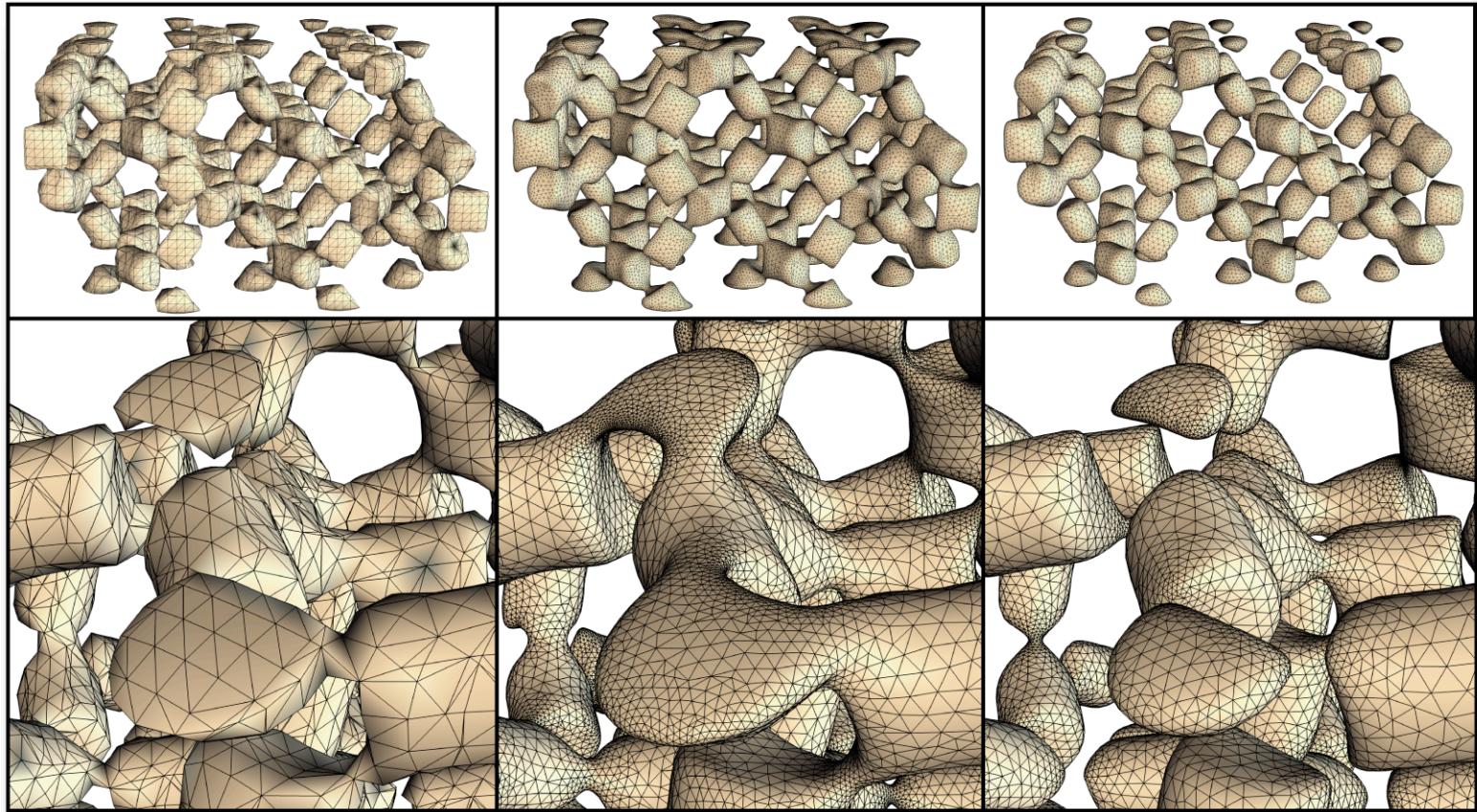


Figure 4: Isosurfacing a structured grid of a silicon lattice simulation. From left to right: marching cubes output, and our method for $\rho = 0.3$, using respectively Catmull-Rom and B-splines for reconstruction.

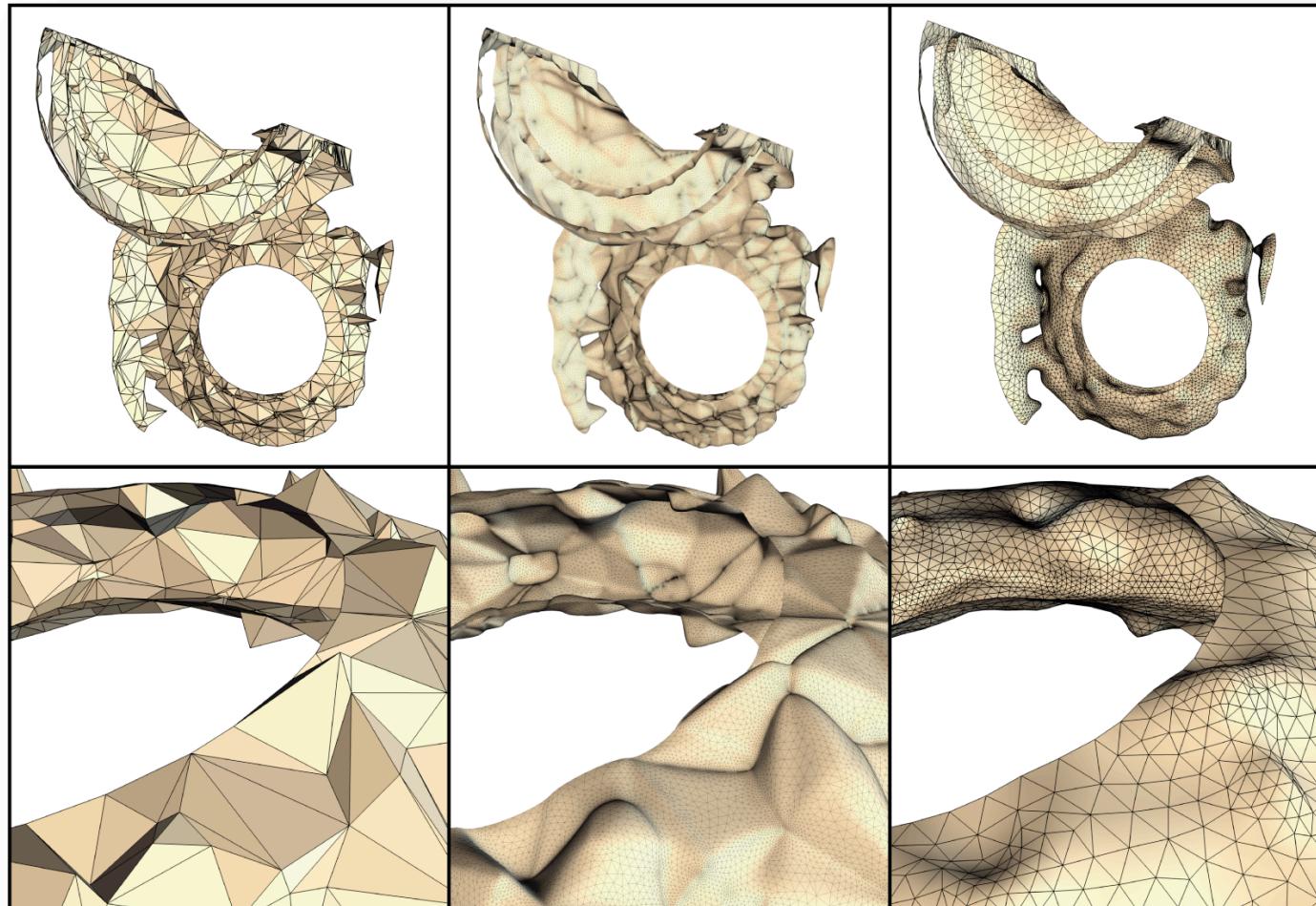
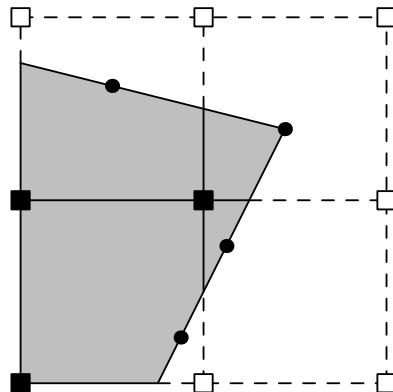
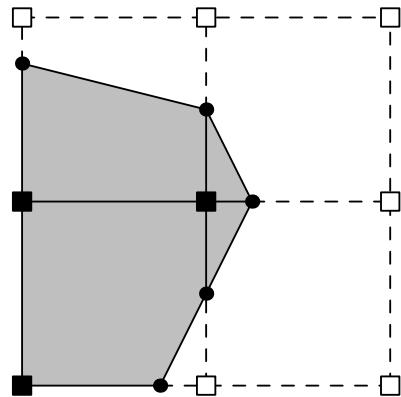
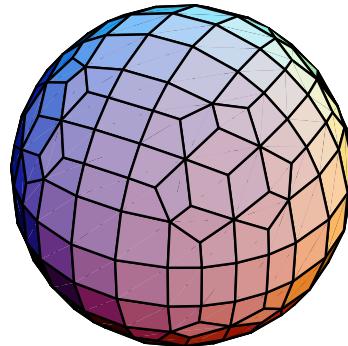
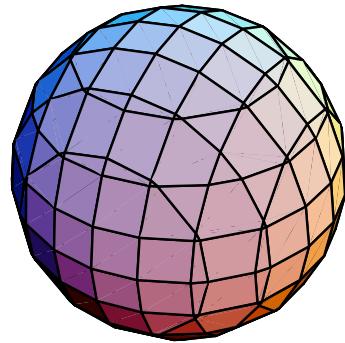


Figure 5: Isosurfacing unstructured grids. From left to right: MT output, and our method for $\rho = 0.5$, using respectively Nielson interpolation and Moving Least Squares for reconstruction.

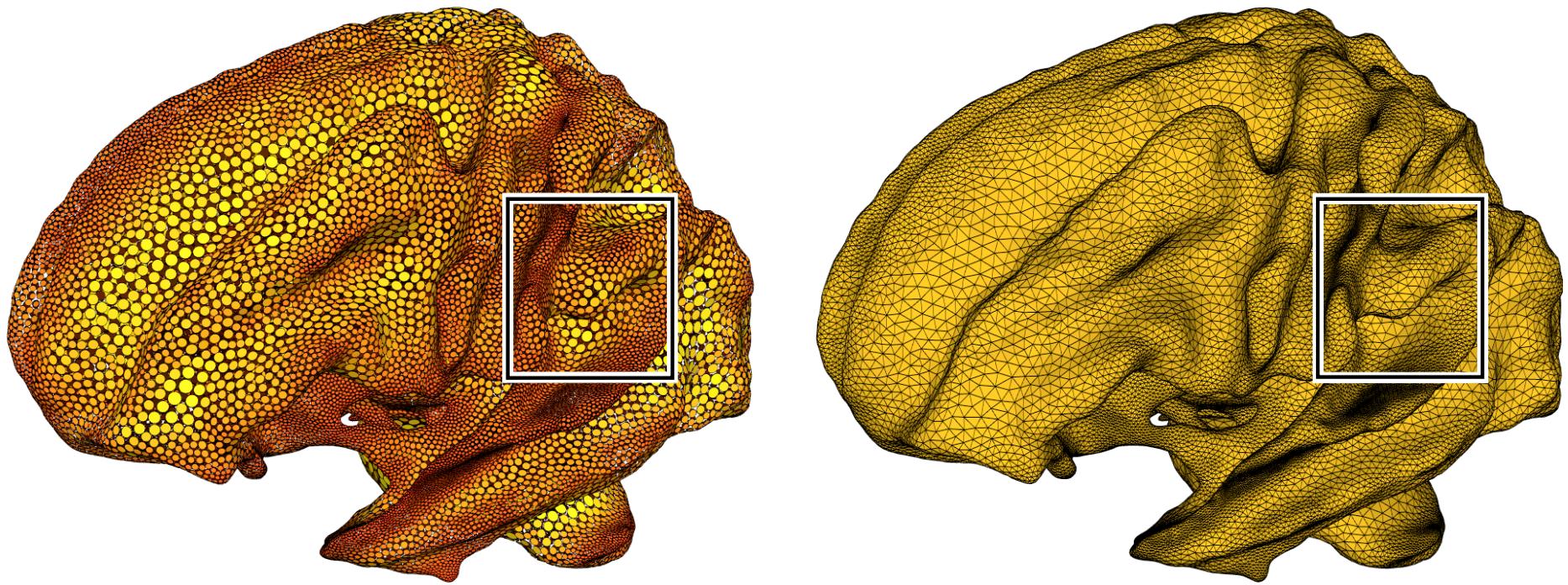
Dual Contouring



Dual Contouring of Hermite Data

Tao Ju, Frank Losasso, Scott Schaefer, Joe Warren
Rice University*

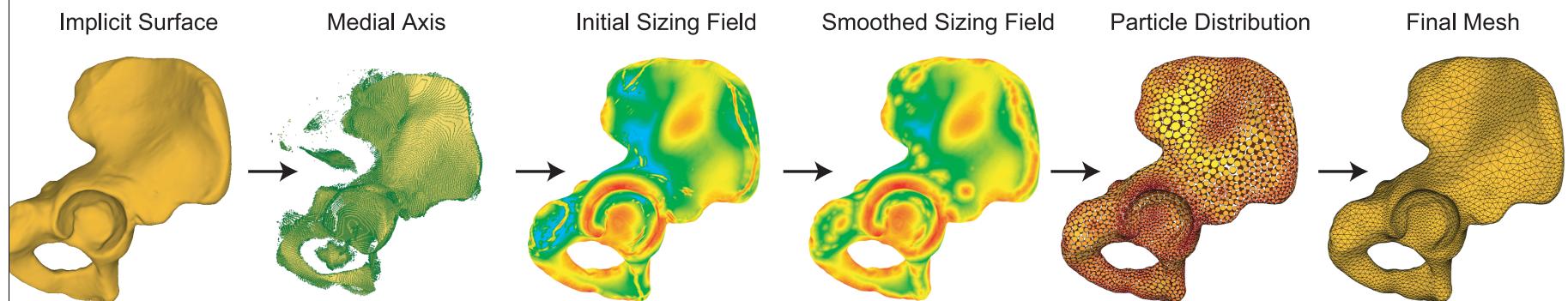
Particle Systems



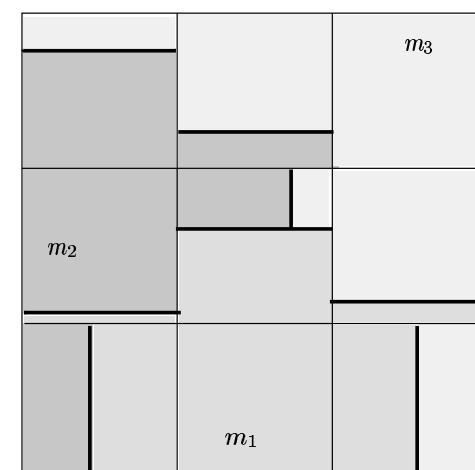
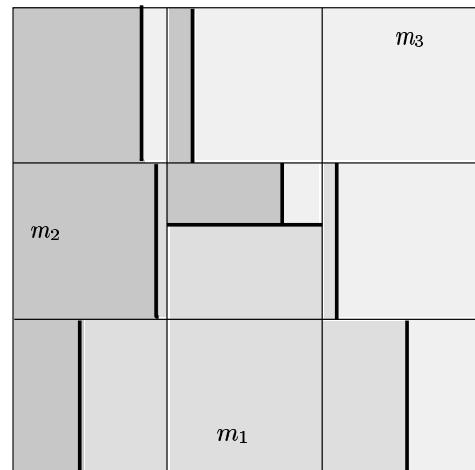
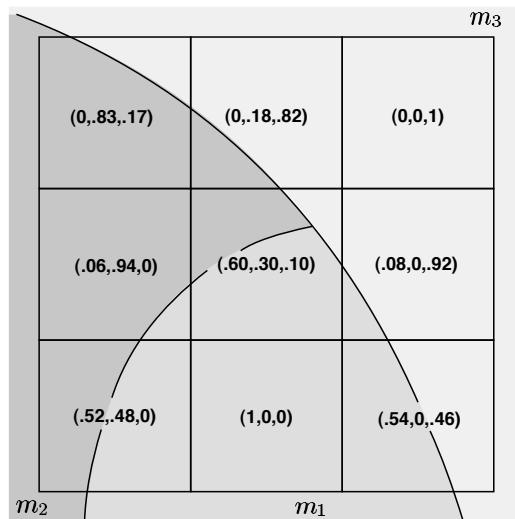
Topology, Accuracy, and Quality of Isosurface Meshes Using
Dynamic Particles

Miriah Meyer, *Student Member, IEEE*, Robert M. Kirby, *Member, IEEE*, and Ross Whitaker, *Member, IEEE*

Particle Systems



MATERIAL INTERFACE RECONSTRUCTION



Kathleen S. Bonnell¹

Mark A. Duchaineau²

Daniel R. Schikore³

Bernd Hamann⁴

Kenneth I. Joy⁵

